

Application/Control No	. Applicant(s)/Patent und Reexamination	ler
10/019,788	LEBOUILL, GILLES	
Examiner	Art Unit	
Baotran N. To	2135	

SEARCHED				
Class	Subclass	Date	Examiner	
726	2 and 12	8/8/2007	вт	
713	155, 161	8/8/2007	ВТ	
713	168, 172	8/8/2007	ВТ	
713	185	8/8/2007	ВТ	
709	224, 229	8/8/2007	ВТ	
705	30	8/8/2007	вт	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u>- L</u>			

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST SEARCH (USPAT; USPGPUB; EPO; JPO; DERWENT; IBM_TDB)	8/8/2007	ВТ
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